

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/566,280	WANG ET AL.
	Examiner	Art Unit
	RIP A. LEE	1796

SEARCHED

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
525	240	1/20/2010	RL
525	232	1/20/2010	RL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**